

<b>Notice of References Cited</b>	Application/Control No. 10/722,548		Applicant(s)/Patent Under Reexamination KWOK ET AL.	
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	B	US-6,108,064	08-2000	Minoura et al.	349/130
	C	US-2002/0097362	07-2002	Yamada et al.	349/130
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	K	US-			
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**NON-PATENT DOCUMENTS**

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